Hystersis like behaviour in Thin Films with heating-cooling cycle.

 $P.Arun^1$ and $A.G.Vedeshwar^1$

¹Department of Physics & Astrophysics, University of Delhi, Delhi - 110 007, India

The expression of temperature distribution along a lm thickness is derived and distribution of temperature in the lm as the substrate is heated is shown. The variation of lm resistance with di erent substrate temperature is calculated and the existence of temperature gradient along the lm thickness with nite therm al conductivity leads to hysteresis like behaviour on heating-cooling

the lm .

PACS num bers: 73.61; 73.61.G; 81.40.C

I. IN TRODUCTION

The electrical conductivity measurements are in portant in characterising conducting or semiconducting materials, both in their thin lm and bulk state. It is routinely carried out for various materials. The temperature dependence of resistivity yields information about intrinsic band gap of the material, the activation energy for conduction in lm s due to grain boundary barrier height or in purity activation energy etc. For the above estimation, the resistance measurement are taken either in the heating or cooling direction of temperature variation. If the system is heated or cooled very slow ly, i.e. with same rate of change of temperature, both the heating and cooling cycles coincide. However, considerable di erence has been observed when an am orphous lm is heated above crystalline transition temperature and cooled back to room temperature. This can be understood as due to structural changes^{1,2,3}. In such cases after cooling, most of the lm s do not regain their initial resistance. However some did regain their initial resistance, thus enclosing an area as in hysteresis bops. Hysteresis have been observed in bism uth lm s even without structural changes⁴ where the heating and cooling rates were kept di erent. This is interesting and since no attempt is made to explain this variation, in this manuscript we attempt to explain the appearance of hysteresis due to non-equilibrium state of the lm.

II. THEORY

We consider the Im to be kept on a copper block which is heated by a heating coil embedded in it. The heating rate is varied by the voltage applied to the heating coil, such that the whole surface of the copper block is having uniform temperature. The Im is kept on this copper block resulting in heating from the substrate side (g1). The temperature varies along the Im thickness with time. The variation of temperature with time and spatial co-ordinates is given by⁵

$$c_v \frac{\partial T}{\partial t} = -\frac{\partial^2 T}{\partial x^2}$$
(1)

where is the therm al conductivity of the lm and ç is the speci c heat of the lm. A solution of this partial di erential equation depends on the initial and boundary conditions of the problem. Depending on the initial and boundary conditions solution would be di erent⁶. The initial condition for the lm of thickness 'd' being heated from the substrate side would be given as

$$T(x = 0; t = 0) = T_{sub}$$
 (2)

$$T(x = d;t = 0) = T_{sur}$$
 (3)

while after a long time the lm would be uniform ly heated, with the surface attaining the same temperature as that of the substrate, i.e.

$$T(x;1) = T_{sub}$$

From the given conditions, we search for a solution of the form

$$T(x;t) = q(x)h(t)$$

Or in other words the variables are separable and thus, solving equation (1) by separable variable m ethod we have the solution

$$T(x;t) = a + bsin \frac{x}{2d} e^{\frac{2}{4d^2}}$$
(4)

where D is the therm aldi usivity, $=c_v$. Applying the conditions stated in (2) and (3) the above solution may be written as

$$T(x;t) = T_{sub} (T_{sub} T_{sur}) \sin \frac{x}{2d} e^{\frac{2_{Dt}}{4d^2}}$$
 (5)

Under experimental conditions, where resistivity or resistance is measured as a function of temperature, the substrate temperature would be continuously changing with time i.e. would be time dependent. Hence the above equation can not be used as it is. Numerically, rst the surface temperature is calculated for a given substrate temperature at a given instant, along with temperatures along the thickness of the lm. The new surface temperature can be plugged back into the expression along with the new substrate temperature. This scenario is valid for lm's with m oderate therm al conductivity. Too carry out such a numerical calculation we assume the substrate temperature to vary with time during the heating cycle as

$$T_{sub}(t) = P(1 e^{Qt}) + R$$

where 'R' is the room temperature. We have numerically determined the distribution of temperature along the thickness of 1000A In softwarying di usivity, as described in the last section. Figure 2 shows the variation of temperature along the thickness of three di erent di usivities (a) 5 $10^{3}A^{2}$ =sec, (b) 5 $10^{2}A^{2}$ =sec and (c) 5 $10^{3}A^{2}$ =sec. D iffusivity, as already stated is the ratio of therm al conductivity to the speci c heat of the material. C om paring three di erent di usivity of same thickness in plies di erent materials of same thickness is being studied. If we assume there is not much variation in speci c heat, the comparative study is being done for materials of varying therm al conductivity (1). For numerical computation we assume the values of the constants of equation (1) to be 360°C, 0:00039sec ¹ and 14:5°C for P, Q and R respectively. The saturation temperature that can be attained would be

380°C, which would be very high. Hence, we assume the heater is switched o after 800sec, by which time, the copper block would be at 110°C. The family of curves show the spatial distribution of temperature at various given time, namely after (i) 0 sec, (ii) 200sec, (iii) 400sec, (iv) 600sec and (v) 800 sec of heating. As is evident from gure 2 (a) the surface remains at room temperature since heat does not spread to the surface though the substrate is getting hotter with time. This is due to the poor therm al conductivity of the lm. This di erence in surface and

substrate tem perature decreases with time as can be understood from g 2 (b) and (c).

If the heating and cooling is done in vacuum the cooling of the lm, i.e. bas of heat can take place by IR radiation bases or by conduction through the substrate side. A fler the heater is switched o , since the process is in vacuum, the substrate tem perature remains constant for an appreciably long time before it starts falling. We assume that the fall in substrate tem perature takes place after 200sec from instant that the heater is switched o . Due to the tem perature gradient present along the thickness of the lm, the surface tends to attain the same tem perature as the substrate. Figure 3 shows the tem perature along the thickness of the lm at various time, between the instant when the heater was switched o to 200 sec after it was switched o . It can be seen from gure 3 (a), the spatial distribution of tem perature remains the same even after 200 sec due to the poor them alconductivity of the lm. However, as can be seen from g 3 (b) and (c), with im proving them alconductivity, the lm eventually attains equilibrium with time.

The variation of the substrates tem perature with time is taken as

$$T_{sub} = Se^{ut} + R$$

where S is the maximum temperature that the substrate had reached in the heating cycle, before the onset of cooling. For computation of the temperature distribution, to maintain assumption that the rate of cooling is very dimentificement from the heating rate, 'u' is taken as 0:00012sec¹. Figure 4 shows the temperature distribution along the length of the lm at regular intervals after the onset of cooling. For the lm of low thermal conductivity (g 4 a), the distribution pro le is very similar to that of heating cycle as shown in g 3 (a). How ever, as exhibited by gure 4 (b) and (c), the pro le is dimension for lm swith better thermal conductivity, where in some cases (4c, ii-v), the surface is seen to at a higher temperature then the substrate. This immediately suggests there would be some dimension in properties, such as resistance, during heating and cooling cycle.

3

III. FILM RESISTANCE

The lm can be thought of an numerous in nitesimal identical thin layers, one on top of the other. All the layers acting as resistive elements with the net resistance of the lm being the elect of these resistance appearing in parallel combination. Since the layers are identical, at room temperature all of them have equal value. However, due to the metallic/sem iconducting nature of the lm, the resistance of these layers vary with temperature. The variation of resistance with temperature is given as

$$R = R_{\circ} (1 + T)$$

where and R_o are the tem perature coe cient of tem perature (TCR) and the resistance of the identical layer. For the case $T = 0^{\circ}C$, the lm s resistance would be given as

$$\frac{1}{R} = \sum_{i=1}^{K} \frac{1}{R_o} = \frac{n}{R_o}$$
(6)

The TCR is positive for m etal while it is negative for sem iconductors. Since, spatial distribution of tem perature was calculated for various substrate tem peratures at various instant, the lm s resistance can be trivially calculated as a function of substrate tem perature and time.

Figures 5-7 were plotted with data generated assuming the 1000A thick Im to be made up of 10 resistive layers in parallel combination, with each layer to have a room temperature resistance of 170K and = 0.80^{-30} C⁻¹. These numerical values are taken from our previous study on Sb₂Te₃ Im \vec{s} . Figure 5 shows the variation of resistance with substrate temperature. As can be seen Im s with moderate therm al conductivity and those with good therm al conductivity enclose very sm allarea. How ever, Im s with intermediate di usivity enclose large area due to aggravated di erence between the heating and cooling cycle.

Figure 7 is of interest. The TCR or the variation of resistance with temperature has been calculated for various di usivity. It is evident that the TCR of good therm ally conducting lm sm atch the TCR of it's constituent in nitesim althin layer of which the lm is made of. For a mathematical analysis consider the lm to be made up of in nite strips of layer, such that each neighbouring layer has a slightly di erent temperature and intum a slightly di erent resistance. The summation sign of equation (6) may then be replaced by an integration sign, hence the net resistance of the lm would be given as

$$\frac{1}{R} = \frac{1}{R_{o}} \frac{\sum_{n=d=a}^{Z_{n=d=a}} \frac{di}{(1+T)}$$

At an given instant the tem perature is given by equation (5), hence the above equation can be re-written as

$$\frac{R_{o}}{R} = \frac{\frac{Z_{n}}{1}}{\frac{1}{(1 + T_{sub})}} \frac{di}{(T_{sub} - T_{sur})e^{\frac{-Z_{D,t}}{4d^{2}}}sin \frac{1}{2n}i}$$
(7)

5

For solving the above equation, we substitute

$$A = 1 + T_{sub}$$
$$B = (T_{sub} T_{sur})e^{\frac{2}{4d^2}}$$
$$x = \frac{1}{2n}i$$

Thus, equation (7) can be written as

$$\frac{R_{o}}{2nR} = \int_{0}^{Z_{o}=2} \frac{di}{A - B \sin \frac{di}{2n}i}$$
(8)

$$\frac{R_{o}}{2nR} = \frac{1}{P \frac{1}{A^{2} B^{2}}} \tan^{-1} \left(\frac{r}{\frac{A+B}{AB}}\right)$$
(9)

As the lm's di usivity increases, the term B becomes smaller and smaller, i.e. tends to zero. The above equation then reduces to

$$\frac{R_{o}}{2nR} = \frac{1}{A} \tan^{-1} (1) = \frac{1}{2A}$$

or

$$\frac{nR}{R_{o}} = 1 + T$$

on re-arranging

 $R = \frac{R_{\circ}}{n} (1 + T)$

using the equation showing rise in temperature with time, we have

$$\frac{\mathrm{dR}}{\mathrm{dt}} = \frac{\mathrm{R}_{o}}{\mathrm{n}} (\mathrm{PQe}^{\mathrm{Qt}})$$

and

 $\frac{dT}{dt} = PQe^{Qt}$

Thus the lm 's TCR works out as

$$TCR_{film} = \frac{n}{R_{o}}\frac{dR}{dT} =$$

The mathematics show that not only does a good thermally conducting lm's TCR match that of the in nitesimal thin layer of which the lm is made of, it is also independent of the rate of heating/ cooling. It can be inferred that the TCR of the lm's with lower thermal conductivity would show dependence on the rate of heating and cooling.

This can be seen from gure 8. Figure 8 shows the e ect the rate of heating would have on the slope, and intum the TCR. The data was calculated in the same manner as discussed in the previous sections. While Figure 8A exhibits the variation of resistance with temperature for a poor them ally conducting $\ln (D = 500 \text{A}/\text{sec})$, Figure 8B is for a good conducting $\ln (D = 500 \text{A}/\text{sec})$. Three curves are present in both gures, each for dimensional methods, namely (i) 3:6 $10^{-3\circ}\text{C} = \text{sec}$, (ii) $72^{\circ}\text{C} = \text{sec}$ and (iii) $216^{\circ}\text{C} = \text{sec}$. All three curves coincide for the conducting $\ln \cdot \text{How ever}$, in the gure 8A, where a low thermal conducting \ln the curves do not coincide and their slopes are dimension. Thus, the TCR values would depend on the rate of heating and cooling. An interesting feature is that the resistances at various temperatures of a poor conducting $\ln m$ easured at very low heating rates match those of a good conducting \ln being heated rapidly.

IV. CONCLUSIONS

The electrical studies of thin Im s are usually done by heating the sam ple and measuring resistance/resistivity with tem perature. Though, the measurements are to be done after the Im has attained a steady tem perature, usually the measurement is done as the Im is being heated or cooled. As discussed in the article, if the Im has a mite therm all conductivity (i.e. it is not metallic), one essentially is making measurement in non-equilibrium conditions. Thus, parameters like TCR etc. computed is not only material dependent but depends on conditions of the experiment, e.g. the rate of heating or cooling. It is essentially due to this non-equilibrium measurement that leads to a loop like formation due to the heating-cooling cycle.

A cknow ledgm ents

The authors would like to acknow ledge the contributions of Prof. S.R. Choudhury, Pankaj Tyagiand Naveen Gaur.

E lectronic address: arunp920 physics.du.ac.in, arunp920 yahoo.co.in, agni0 physics.du.ac.in

- ¹ V.Dam odara Das and D.Karunakaran, Phys.Rev.B., 39 (1989) 10 872.
- ² V.Dam odara Das and P.G opalGanesan, Solid State Commun., 106 (1998) 315.
- ³ V.Dam odara Das and S.Selvara j J.Appl Phys., 83 (1993) 3696.
- ⁴ K.Jayachandran and C.S.M enon, Pram ana, 50 (1998) 221.
- ⁵ H.S.Carslaw and J.C.Jaeger, "Conduction of Heat in Solids", (Oxford Univ. Press, Oxford 1954).
- ⁶ S.M. Sze, "Sem iconductor D evices, Physics and Technology", (W iley, New York1993).
- 7 P.A run and A.G.Vedeshwar, presented for publication in Physica B.

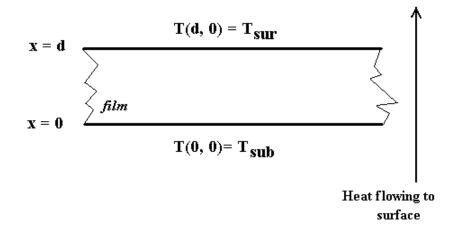


FIG.1: Direction of heat f ow and initial condition of temperature on both surfaces of the f m.

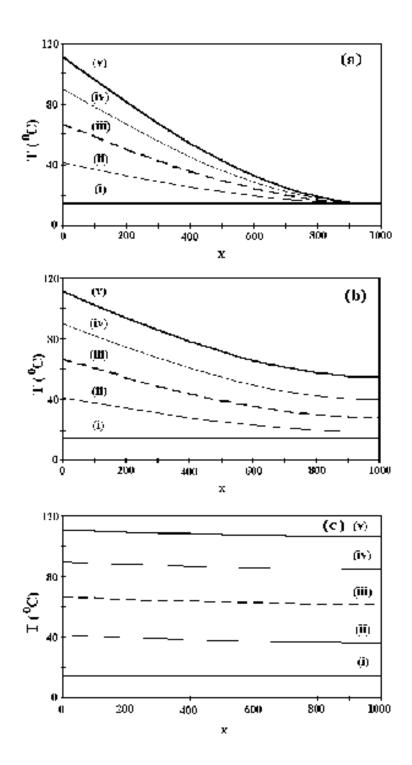


FIG. 2: Variation of temperature along the thickness of a 1000A thick lm of di erent di usivity (a) 5 10^3 A=sec, (b) 5 10^2 A=sec and (c) 5 10^3 A=sec after (i) 0 sec, (ii) 200 sec, (iii) 400 sec, (iv) 600 sec and (v) 800 seconds of substrate heating.

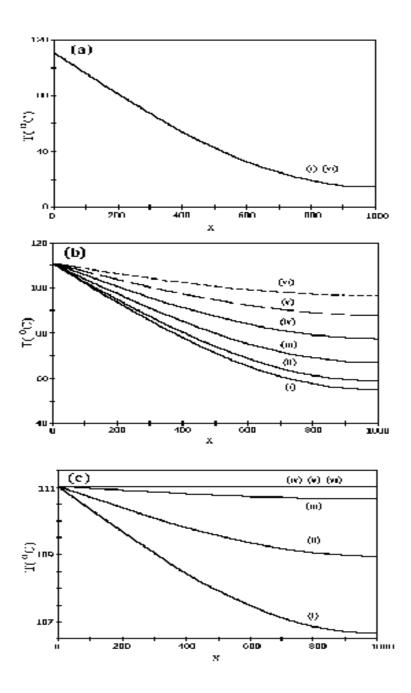


FIG. 3: Variation of temperature along the thickness of a 1000A thick lm of di erent di usivity (a) 5 10^3 A = sec, (b) 5 10^2 A = sec and (c) 5 10^3 A = sec after (i) 0 sec, (ii) 40 sec, (iii) 80 sec, (iv) 120 sec, (v) 160 sec and (vi) 200 seconds after the source of heating was switched o .

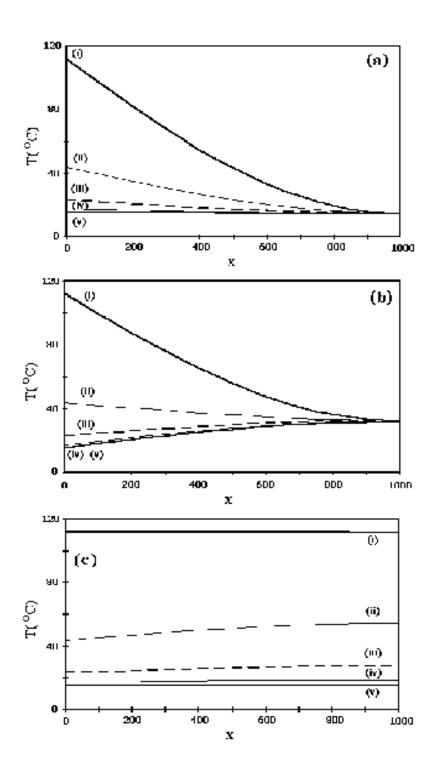


FIG. 4: Variation of temperature along the thickness of a 1000A thick lm of di erent di usivity (a) 5 10^3 A = sec, (b) 5 10^2 A = sec and (c) 5 10^3 A = sec after (i) 8000 sec, (ii) 16000 sec, (iii) 24000 sec, (iv) 32000 sec and (v) 40000 seconds after the setting in of the lm's cooling.

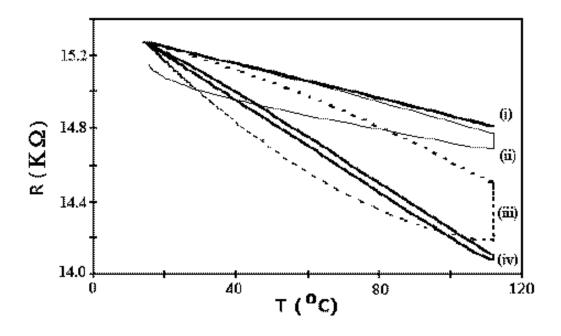


FIG.5: Hysteresis loops formed in lm resistance with the heating -cooling cycle. The calculations were done for lm thickness of 1000A and di usivity (i) 5 $10^{3} A^{2}$ =sec, (ii) $50A^{2}$ =sec, (iii) 5 $10^{2}A^{2}$ =sec and (iv) 5 $10^{3}A^{2}$ =sec.

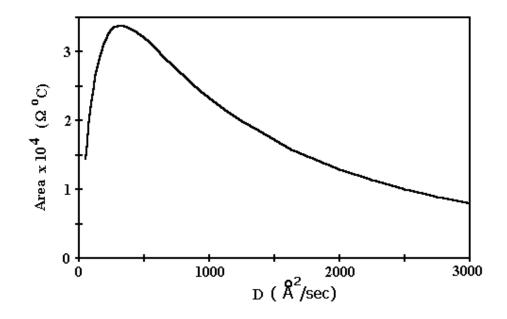


FIG.6: The variation in the area enclosed by loops formed during the resistance variation with temperature during heatingcooling cycles. The variation is due to the di erence in the lms di usitivity.

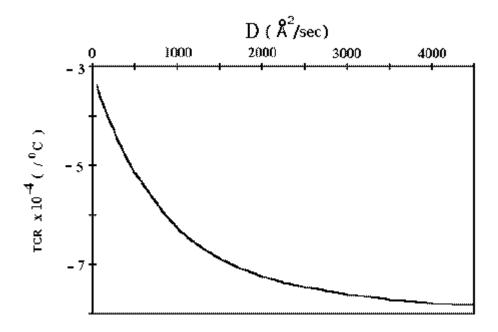


FIG.7: Computed TCR for lms of di erent di ustivity, where the lms are assumed to be of same thickness and made up of num erous layers, with all the layers having the same TCR.

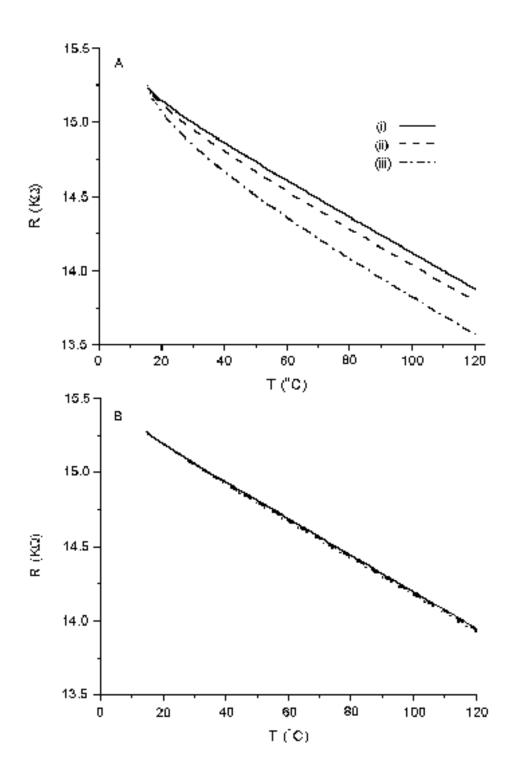


FIG. 8: Figure exhibits the change of resistance of with temperature for (A) a poor therm al conducting lm and (D = $5 \ 10^2 A = sec$) (B) a good therm ally conducting lm (D = $5 \ 10^3 A = sec$). The heating rates were m aintained di erent (i) 3:6 $10^{3\circ} C = sec$, (ii) $72^{\circ}C = sec$ and (iii) $216^{\circ}C = sec$.